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Am ndm nts to the Claims

Claims 1-60 (Cancelled).

61. (New) A semiconductor construction comprising:

a first conductive pillar having a lower portion disposed between a first pair of wordlines and an upper portion extending at least partially over each of the first pair of wordlines;

a first conductive stem in contact with the first conductive pillar, the first conductive stem being formed by a process comprising:

forming an insulative layer over the conductive pillar;

forming a conductive material over the insulative material;

forming a masking material over the conductive material;

utilizing photolithography, patterning an opening through the masking material, the opening having a feature width defined by the photolithography:

narrowing the opening to a narrowed opening;

extending the narrowed opening through the conductive material and through the insulative material; and

depositing a stem material within the extended opening to produce the stem having width that is less than the feature width:

a first pair of laterally opposed fins extending laterally from the first conductive stem;
a second conductive pillar having a lower portion disposed between a second pair of
wordlines and an upper portion extending at least partially over each of the second pair of
wordlines:

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a second conductive stem comprising the stem width, in contact with the second conductive pillar; and

a second pair of laterally opposed fins extending laterally from the second stem.

- 62. (New) The semiconductor construction of claim 61 wherein a distance between a first fin comprised by the first pair of opposed fins and a second fin comprised by the second pair of opposed fins is less than the feature width.
- 63. (New) The semiconductor construction of claim 61 wherein the first and second conductive stems comprise polysilicon.
- 64. (New) The semiconductor construction of claim 61 wherein the first and second pair of opposed fins comprise polysilicon.
- 65. (New) The semiconductor construction of claim 61 wherein the first and second pair of opposed fins are coated with a layer of dielectric material.
- 66. (New) The semiconductor construction of claim 61 wherein the first conductive pillar, the first conductive stem, and the first pair of laterally opposed fins are comprised by a first capacitor construction which further comprises a third pair of laterally opposed fins extending laterally from the first conductive stem.

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67. (New) This miconductor construction of claim 66 wherein the first conductive pillar, the first conductive stem, and the first and third pairs of laterally opposed fins each comprise polysilicon.